Notice of Referenc s Cited	Application/Control No. 09/684,227	Applicant(s)/Patent Under Reexamination CHANG ET AL.	
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

FORM PTO-1449 U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE	ATTY DOCKET NO.	SERIAL NO.
	SJO9-1999-0120US1	09/684,227
SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT BY APPLICANT	APPLICANT	
	Chang et al.	
	FILING DATE	GROUP
	October 6, 2000	2652

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EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
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		DOCUMENT NUMBER	DATE	COUNTRY	NAME	CLASS	SUBCLASS	TRANSLATION YES NO
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	AQ		Annotated photograph illustrating use of Micrion ion milling device dated March 9, 1998
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EXAMINER	DATE CONSIDERED

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